# Interferometry

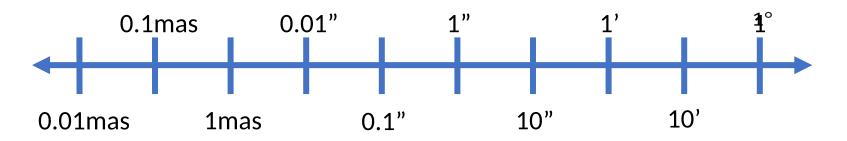
The basics

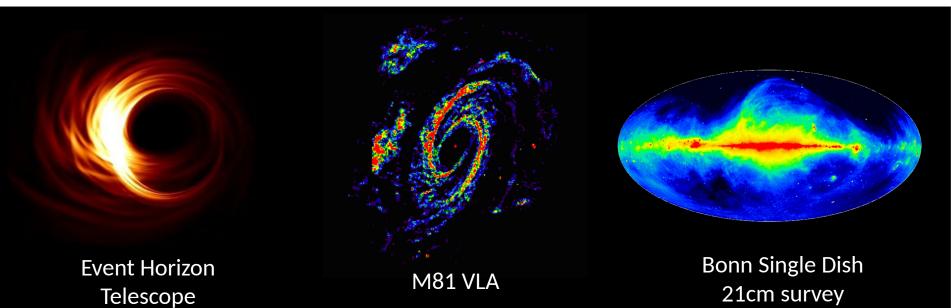
Slides originally by Jack Radcliffe

Based upon N. Jackson's ERIS 2015 lecture

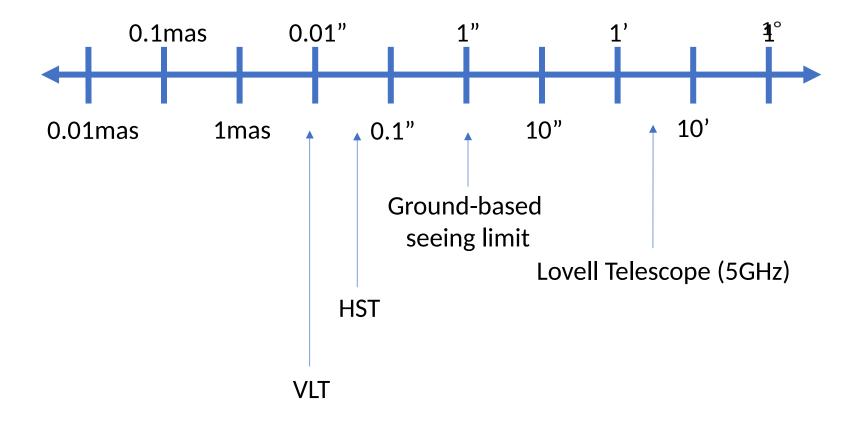
# Why interferometry?

• Single dish vs. interferometers – resolution is key!



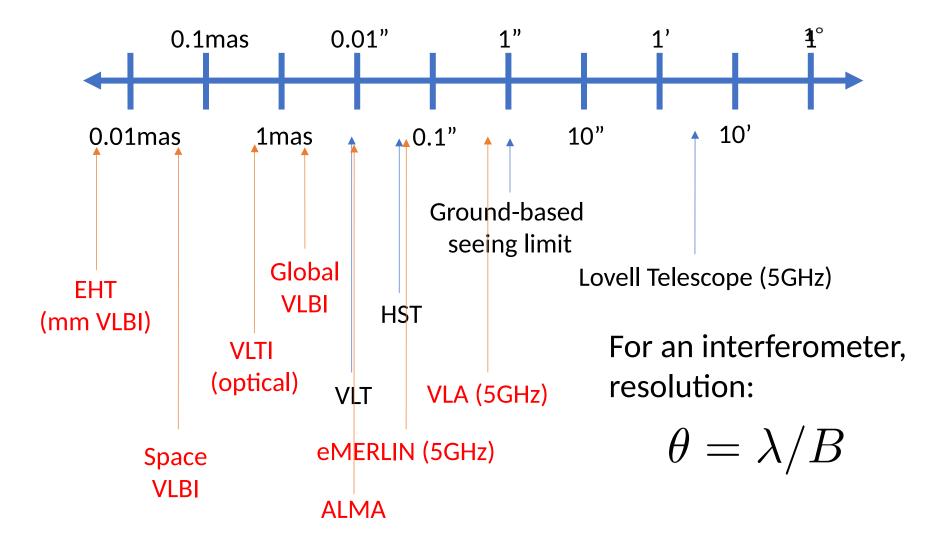


# **Resolution: Single Dish**

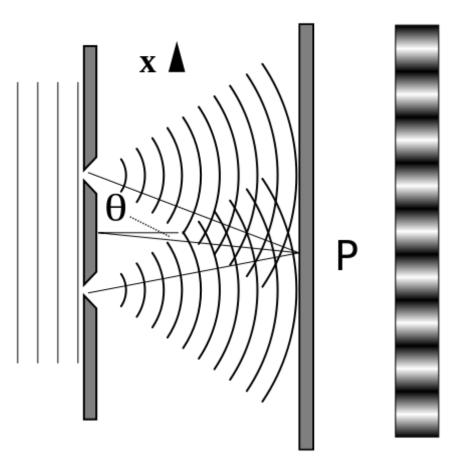


For a single dish, resolution:  $\theta = \lambda/D$ 

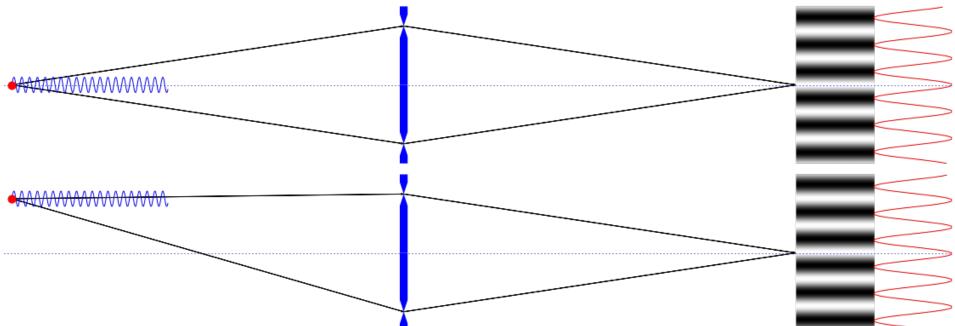
## **Resolution: Interferometers**



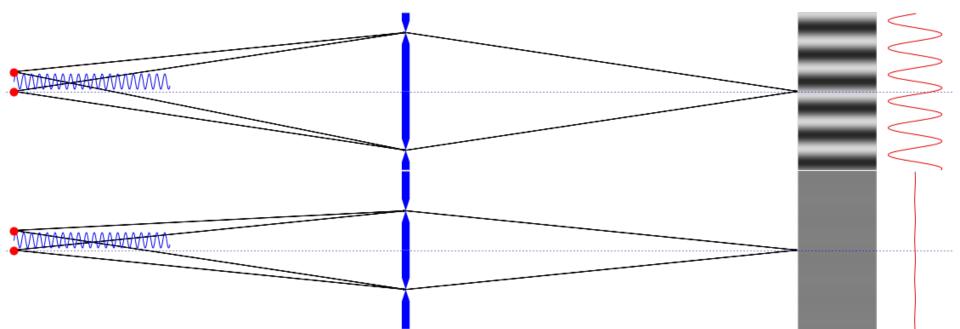
• Young's slits ... see interactive demo



- Single source, two slits
- Increasing the baseline increases the frequency of the fringes
- Increasing the wavelength decreases the frequency of the fringes
- Fringe phase depends on source position
- But with just one baseline/wavelength this is ambiguous several source positions can give the same result
- Use more than one baseline!



- Two sources
- Now destructive interference is possible waves from the two sources can cancel out
- Again with only one baseline various source positions can give the same fringes
- With many baselines we could work out the source separation



- An extended source
- As the source extends the fringes get more blurred
- Amplitude of the fringes encodes source structure (size)
- Phase encodes position (so is constant for this example).
- As the baseline changes the amplitude of the fringes changes – the longer the baseline, the weaker the extended source becomes

# Visibilities

- What we are measuring is called the visibility of the source seen through the double slit
- Amplitude encodes structural information; phase encodes positional information
- Can denote this by one complex number, the complex visibility  $Ae^{i\theta}$
- Historically the first use of interferometers in astronomy was of this type – a Michelson interferometer was used to measure the size of stars

# The 'visibility' is a Fourier transform!

- The fringe visibility of an interferometer gives information about the Fourier transform of the sky brightness distribution.
- Long baselines record information about the small-scale structure of the source but are INSENSITIVE to large-scale structure (fringes wash out)
- Short baselines record information about large-scale structure of the source but are INSENSITIVE to small-scale structure (resolution limit)

# How to combine signals

- Non photon limited (e.g. radio):
  - Electronic, relatively straightforward: can clone and combine signals
  - 'Correlation' (multiplication+delay)
  - Can record signals and combine later
- Photon limited case:
  - Use classical Michelson/Fizeau arrangements
  - Delay lines for manipulation cannot clone photons !

## Two element interferometer

 $I(\sigma)$ • The setup:  $\sigma$ S 1 S Ο  $\mathbf{B}.\mathbf{s}$ h Correlate R2 1 R

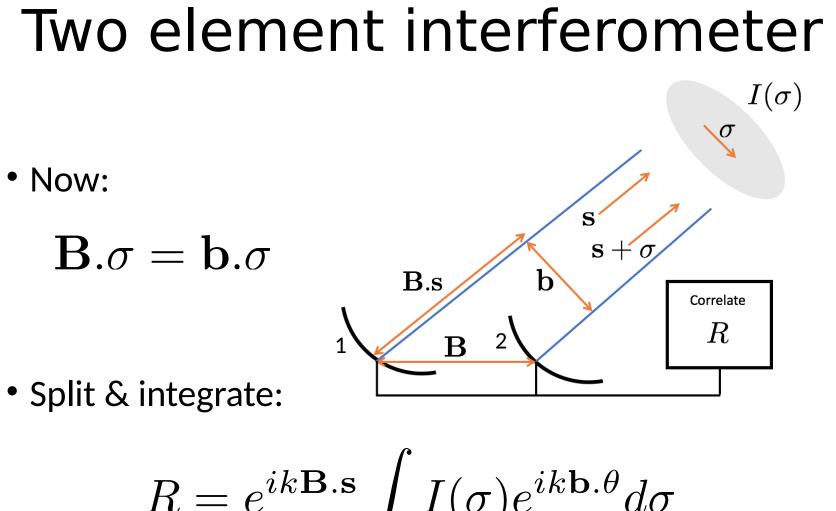
## Two element interferometer

• The maths:

- $I(\sigma)$   $\sigma$   $S + \sigma$   $S + \sigma$   $S + \sigma$  Correlate R
- A multiplying interferometer:

$$R = \langle E_1^* E_2 \rangle = E_1 E_2 e^{ikx}$$

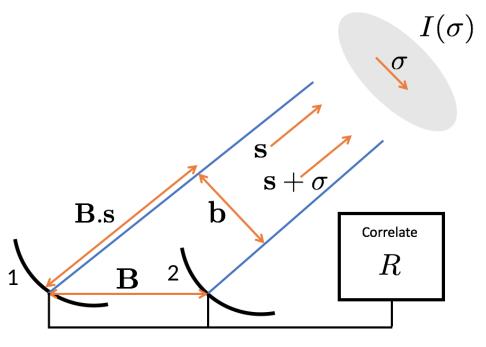
$$dR = dI(\sigma)e^{ik\mathbf{B}.(\mathbf{s}+\theta)}$$



$$R = e^{ik\mathbf{B}.\mathbf{s}} \int I(\sigma) e^{ik\mathbf{b}.\theta} d\sigma$$

## Two element interferometer

- Now in 2D assume:
  - $\sigma = \sigma(x, y)$  $\mathbf{b} = \mathbf{b}(u, v)$



• Therefore:

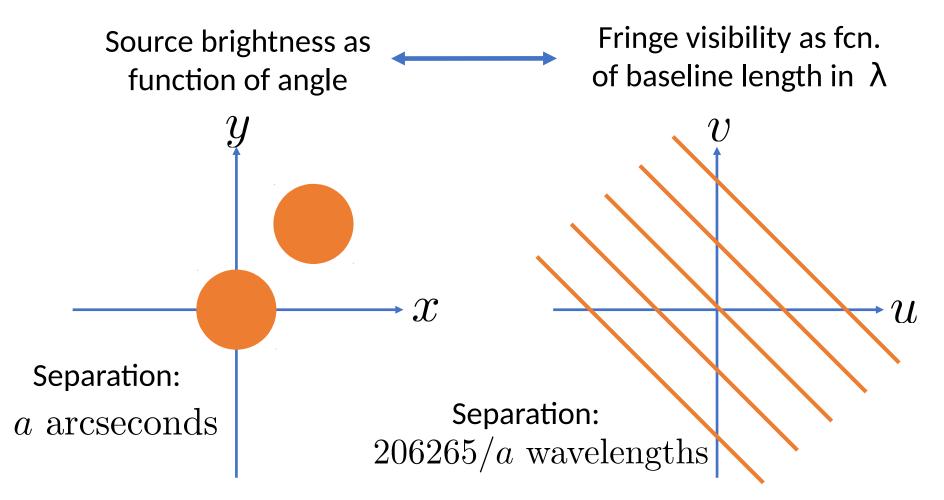
$$R(u,v) = e^{ik\mathbf{B}.\mathbf{s}} \int I(x,y) e^{2\pi i(ux+vy)} dxdy$$

$$R(u,v) = e^{ik\mathbf{B}.\mathbf{s}} \int I(x,y) e^{2\pi i(ux+vy)} dxdy$$

- First term just depends on baseline separation and can be dropped
- Otherwise this relation describes the visibility of a series of fringes and is the 2D Fourier transform of the source brightness distribution.
- R(u,v) has amplitude and phase; both are interesting!

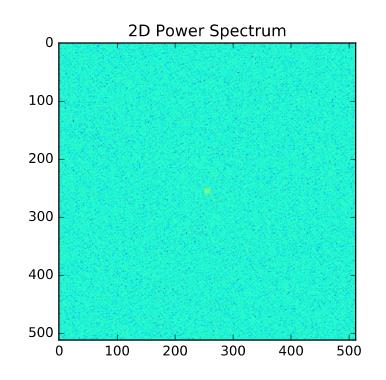
# uv plane

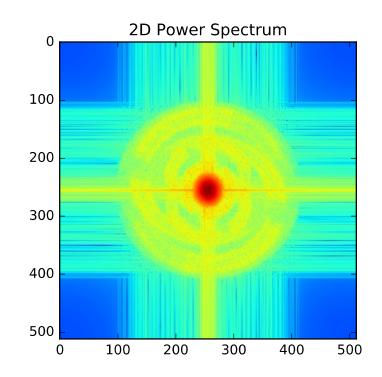
• Direct relationship between x,y and u,v



# Imaging

- If we could measure R(u,v) for all u,v, transform
  -> image
- But we don't! We can only put elements at fixed positions
   Optical
   Radio Interferometer

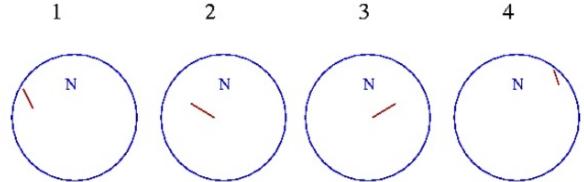




#### Earth Rotation Aperture Synthesis

Let's get some help by using the rotation of the Earth



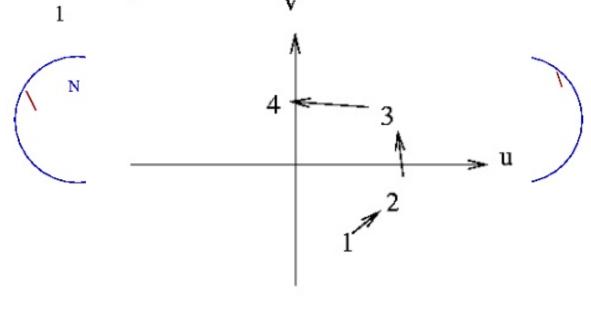


- Can measure many points in uv plane with a single baseline
- Locus is an ellipse;
  the longer the baseline,
  the larger the uv
  distance (higher
  resolution)

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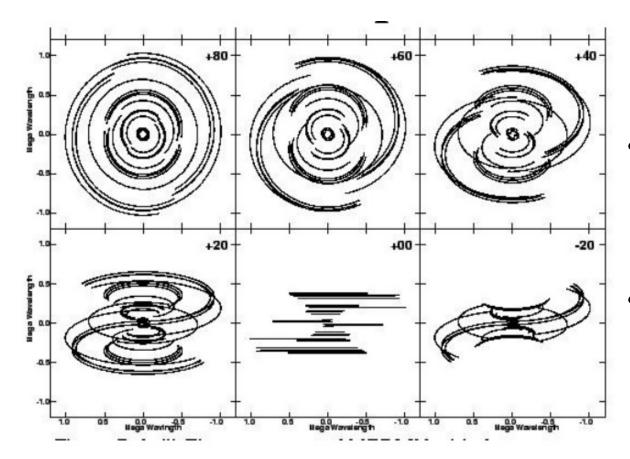




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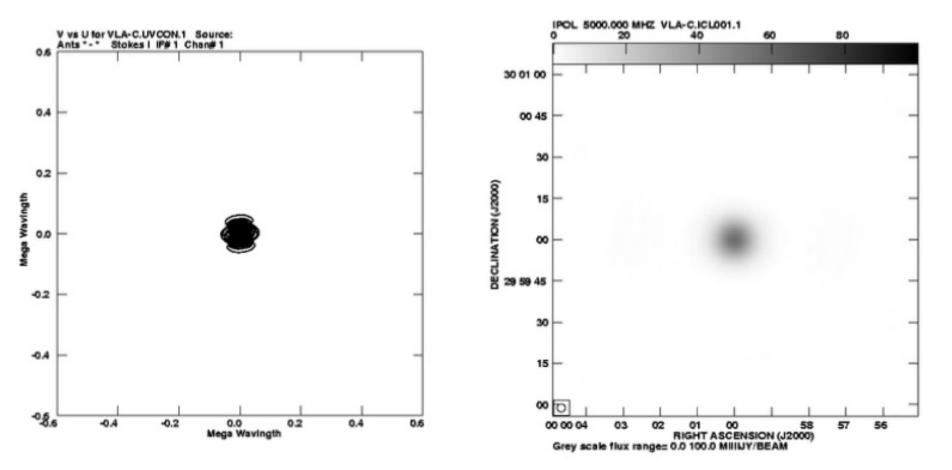
## uv tracks

• E.g. MERLIN



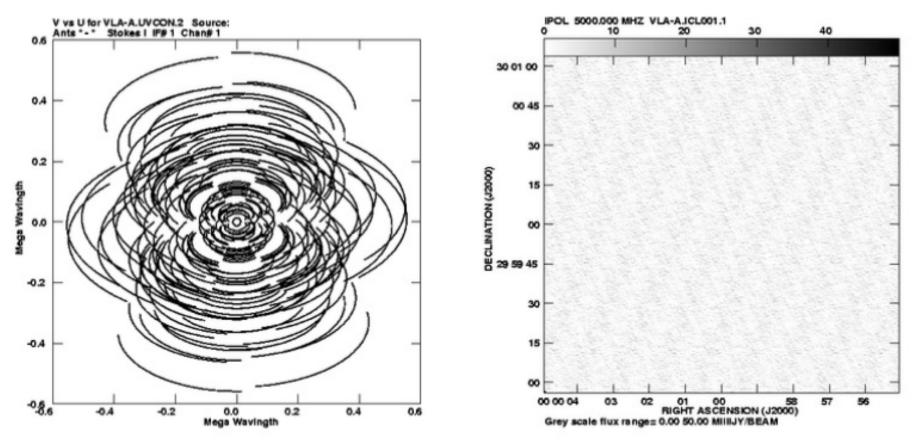
- MERLIN in Northern hemisphere
- Elongated at low declination

#### FT imaging is not like direct imaging!



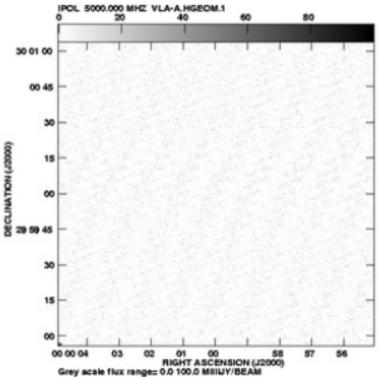
12 arcsec source mapped with uv coverage giving 3 arcsec resolution

#### FT imaging is not like direct imaging!



Multiply all baseline lengths by 10 = higher resolution (0.3 arcsec). No image! But **you can get it back by smoothing, right**?

#### FT imaging is not like direct imaging!

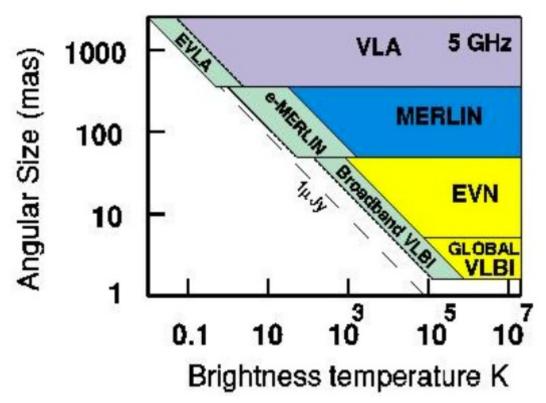


Wrong! Smoothed image to 3" shows no source.

Moral: longer baselines are INSENSITIVE to the large-scale structure – unlike direct imaging you lose it IRRETRIEVABLY. Use the range of baselines appropriate to the problem.

# This is why you need interferometers....

... and more than one of them!



- JVLA 30m36km
- eMERLIN 6km-250km
- EVN 250km-2300km
- VLBA 250km-9000km
- Global VLBI 12000km
- Space VLBI 32000km